

Search Notes

Application No.

10/639,925

Examiner

Toan M Le

Applicant(s)

PREIKSAS ET AL.

Art Unit

2863

SEARCHED

Class	Subclass	Date	Examiner
702	107	2/3/2005	TL
250	396R	2/2/2005	TL
250	201.3	2/3/2005	TL
359	383	2/3/2005	TL
349	17	2/3/2005	TL
382	255	2/3/2005	TL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Electron Microscope, Control, Index	2/3/2005	TL
Electron Microscope, Macro	2/11/2005	TL
Electron Microscope, Computer Control	2/11/2005	TL